MC100EL30

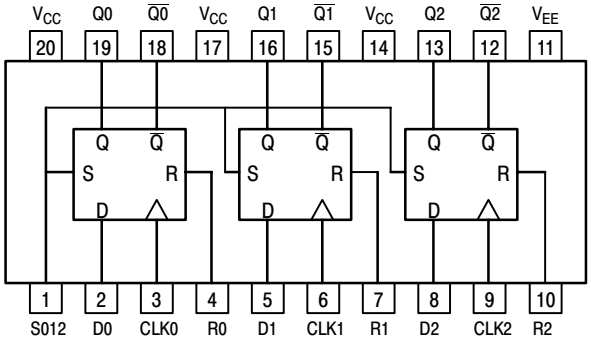
5V ECL Triple D Flip-Flop with Set and Reset

The MC100EL30 is a triple master–slave D flip flop with differential outputs. Data enters the master latch when the clock input is LOW and transfers to the slave upon a positive transition on the clock input.

In addition to a common Set input individual Reset inputs are provided for each flip flop. Both the Set and Reset inputs function asynchronous and overriding with respect to the clock inputs.

- 1200 MHz Minimum Toggle Frequency
- 450 ps Typical Propagation Delays
- ESD Protection: >2 KV HBM
- The 100 Series Contains Temperature Compensation.
- PECL Mode Operating Range: V_{CC}= 4.2 V to 5.7 V with V_{EE}= 0 V
- NECL Mode Operating Range: V_{CC}= 0 V with V_{EE}= –4.2 V to –5.7 V
- Internal Input Pulldown Resistors
- Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test
- Moisture Sensitivity Level 1
  For Additional Information, see Application Note AND8003/D
- Flammability Rating: UL–94 code V–0 @ 1/8”,
  Oxygen Index 28 to 34
- Transistor Count = 347 devices

Logic Diagram and Pinout: 20-Lead SOIC (Top View)



Warning: All V_{CC} and V_{EE} pins must be externally connected to Power Supply to guarantee proper operation.

PIN DESCRIPTION

PIN	FUNCTION
D0–D2	ECL Data Inputs
R0–R2	ECL Reset Inputs
CLK0–CLK2	ECL Clock Inputs
S012	ECL Common Set Input
Q0–Q2; $\overline{Q0}$–$\overline{Q2}$	ECL Differential Data Outputs
V_{CC}	Positive Supply
V_{EE}	Negative Supply

TRUTH TABLE

R*	S*	D*	CLK*	Q	$\overline{Q}$
L	L	L	Z	L	H
L	L	H	Z	H	L
H	L	X	X	L	H
L	H	X	X	H	L
H	H	X	X	Undef	Undef

Z = LOW to HIGH Transition
X = Don’t Care

* Pins will default low when left open.

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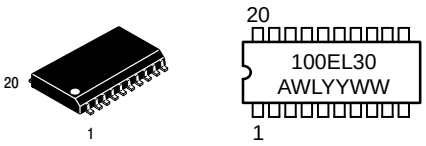
MARKING DIAGRAM*



SO–20
DW SUFFIX
CASE 751D

A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week

*For additional information, see Application Note AND8002/D

ORDERING INFORMATION

Device	Package	Shipping
MC100EL30DW	SO–20	38 Units/Rail
MC100EL30DWR2	SO–20	1000 Units/Reel

MAXIMUM RATINGS (Note 1.)

Symbol	Parameter	Condition 1	Condition 2	Rating	Units
V_{CC}	PECL Mode Power Supply	V_{EE} = 0 V		8 to 0	V
V_{EE}	NECL Mode Power Supply	V_{CC} = 0 V		–8 to 0	V
V_I	PECL Mode Input Voltage NECL Mode Input Voltage	V_{EE} = 0 V V_{CC} = 0 V	$V_I \leq V_{CC}$ $V_I \geq V_{EE}$	6 to 0 –6 to 0	V V
I_{out}	Output Current	Continuous Surge		50 100	mA mA
TA	Operating Temperature Range			–40 to +85	°C
T_{stg}	Storage Temperature Range			–65 to +150	°C
θ_{JA}	Thermal Resistance (Junction to Ambient)	0 LFPM 500 LFPM	20 SOIC 20 SOIC	90 60	°C/W °C/W
θ_{JC}	Thermal Resistance (Junction to Case)	std bd	20 SOIC	30 to 35	°C/W
T_{sol}	Wave Solder	<2 to 3 sec @ 248°C		265	°C

1. Maximum Ratings are those values beyond which device damage may occur.

PECL DC CHARACTERISTICS V_{CC}= 5.0 V; V_{EE}= 0.0 V (Note 1.)

		–40°C			25°C			85°C			
Symbol	Characteristic	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Unit
I_{EE}	Power Supply Current		55	62		55	62		55	64	mA
V_{OH}	Output HIGH Voltage (Note 2.)	3915	3995	4120	3975	4045	4120	3975	4050	4120	mV
V_{OL}	Output LOW Voltage (Note 2.)	3170	3305	3445	3190	3295	3380	3190	3295	3380	mV
V_{IH}	Input HIGH Voltage	3835		4120	3835		4120	3835		4120	mV
V_{IL}	Input LOW Voltage	3190		3525	3190		3525	3190		3525	mV
I_{IH}	Input HIGH Current			150			150			150	μA
I_{IL}	Input LOW Current	0.5			0.5			0.5			μA

NOTE: Devices are designed to meet the DC specifications shown in the above table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 lfpm is maintained.

1. Input and output parameters vary 1:1 with V_{CC}. V_{EE} can vary +0.8 V / –0.5 V.
2. Outputs are terminated through a 50 ohm resistor to V_{CC}–2 volts.

NECL DC CHARACTERISTICS V_{CC}= 0.0 V; V_{EE}= –5.0 V (Note 1.)

		–40°C			25°C			85°C			
Symbol	Characteristic	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Unit
I_{EE}	Power Supply Current		55	62		55	62		55	64	mA
V_{OH}	Output HIGH Voltage (Note 2.)	–1085	–1005	–880	–1025	–955	–880	–1025	–955	–880	mV
V_{OL}	Output LOW Voltage (Note 2.)	–1830	–1695	–1555	–1810	–1705	–1620	–1810	–1705	–1620	mV
V_{IH}	Input HIGH Voltage	–1165		–880	–1165		–880	–1165		–880	mV
V_{IL}	Input LOW Voltage	–1810		–1475	–1810		–1475	–1810		–1475	mV
I_{IH}	Input HIGH Current			150			150			150	μA
I_{IL}	Input LOW Current	0.5			0.5			0.5			μA

NOTE: Devices are designed to meet the DC specifications shown in the above table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 lfpm is maintained.

1. Input and output parameters vary 1:1 with V_{CC}. V_{EE} can vary +0.8 V / –0.5 V.
2. Outputs are terminated through a 50 ohm resistor to V_{CC}–2 volts.

AC CHARACTERISTICS V_{CC}= 5.0 V; V_{EE}= 0.0 V or V_{CC}= 0.0 V; V_{EE}= –5.0 V (Note 1.)

Symbol	Characteristic	–40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
f_{max}	Maximum Toggle Frequency	1.0			1.2			1.2			GHz
t_{PLH} t_{PHL}	Propagation Delay CLK to Output S, R	460 470		690 710	480 490		710 730	500 515		730 755	ps
t_S t_H	Setup Time Hold Time	150 200	0 100		150 200	0 100		150 200	0 100		ps
t_{RR}	Set/Reset Recovery	400	200		400	200		400	200		ps
t_{PW}	Minimum Pulse Width CLK Set, Reset	400 650			400 650			400 650			ps
t_{JITTER}	Cycle–to–Cycle Jitter		TBD			TBD			TBD		ps
t_r t_f	Output Rise/Fall Times Q (20% – 80%)	280		550	280	450	550	280		550	ps

1. V_{EE} can vary +0.8 V / –0.5 V.

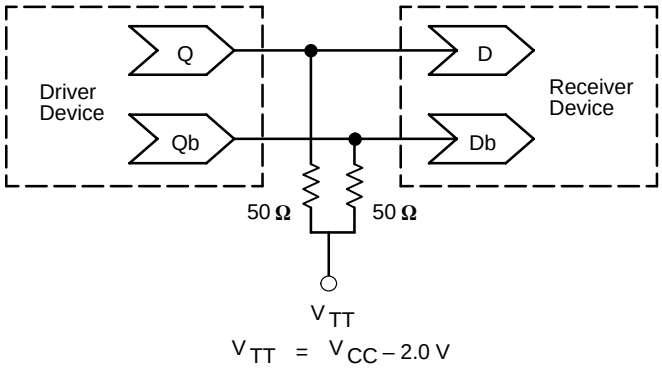


Figure 1. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020 – Termination of ECL Logic Devices.)

Resource Reference of Application Notes

AN1404 – ECLinPS Circuit Performance at Non–Standard V_{IH} Levels

AN1405 – ECL Clock Distribution Techniques

AN1406 – Designing with PECL (ECL at +5.0 V)

AN1503 – ECLinPS I/O SPICE Modeling Kit

AN1504 – Metastability and the ECLinPS Family

AN1560 – Low Voltage ECLinPS SPICE Modeling Kit

AN1568 – Interfacing Between LVDS and ECL

AN1596 – ECLinPS Lite Translator ELT Family SPICE I/O Model Kit

AN1650 – Using Wire–OR Ties in ECLinPS Designs

AN1672 – The ECL Translator Guide

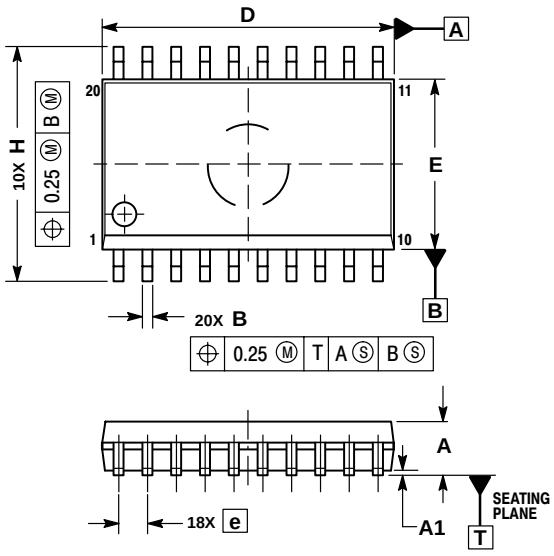
AND8001 – Odd Number Counters Design

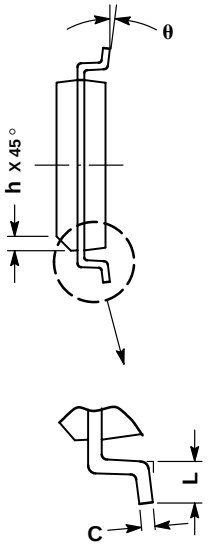
AND8002 – Marking and Date Codes

AND8020 – Termination of ECL Logic Devices

PACKAGE DIMENSIONS

SO–20
DW SUFFIX
PLASTIC SOIC PACKAGE
CASE 751D–05
ISSUE F





NOTES:
1. DIMENSIONS ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
3. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
5. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS	
DIM	MIN	MAX
A	2.35	2.65
A1	0.10	0.25
B	0.35	0.49
C	0.23	0.32
D	12.65	12.95
E	7.40	7.60
e	1.27 BSC	
H	10.05	10.55
h	0.25	0.75
L	0.50	0.90
θ	0°	7°

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